

**FAIRCHILD**  
SEMICONDUCTOR®

## FDFME2P823ZT

### Integrated P-Channel PowerTrench® MOSFET and Schottky Diode -20 V, -2.3 A, 142 mΩ

December 2009

#### Features

- Max  $r_{DS(on)}$  = 142 mΩ at  $V_{GS} = -4.5$  V,  $I_D = -2.3$  A
- Max  $r_{DS(on)}$  = 213 mΩ at  $V_{GS} = -2.5$  V,  $I_D = -1.8$  A
- Max  $r_{DS(on)}$  = 331 mΩ at  $V_{GS} = -1.8$  V,  $I_D = -1.5$  A
- Max  $r_{DS(on)}$  = 530 mΩ at  $V_{GS} = -1.5$  V,  $I_D = -1.2$  A
- Low profile: 0.55 mm maximum in the new package MicroFET 1.6x1.6 **Thin**
- **Schottky:**  $V_F < 0.57$  V @ 1A
- Free from halogenated compounds and antimony oxides
- HBM ESD protection level > 1600V (Note3)
- RoHS Compliant



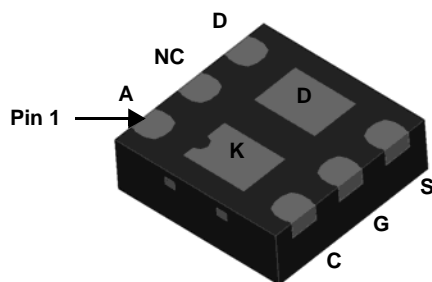
#### General Description

This device is designed specifically as a single package solution for the battery charge switch in cellular handset and other ultra-portable applications. It features as MOSFET with low on-state resistance and an independently connected low forward voltage schottky diode for minimum conduction losses.

The MicroFET 1.6x1.6 **Thin** package offers exceptional thermal performance for its physical size and is well suited to switching and linear mode applications.

#### Applications

- Battery Charging
- DC-DC Conversion

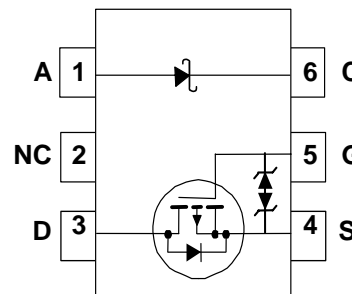


BOTTOM



TOP

MicroFET 1.6x1.6 Thin



#### MOSFET Maximum Ratings $T_A = 25$ °C unless otherwise noted

Symbol	Parameter	Ratings	Units
$V_{DS}$	Drain to Source Voltage	-20	V
$V_{GS}$	Gate to Source Voltage	±8	V
$I_D$	Drain Current -Continuous $T_A = 25$ °C (Note 1a)	-2.3	A
	-Pulsed	-6	
$P_D$	Power Dissipation for Single Operation $T_A = 25$ °C (Note 1a)	1.3	W
	Power Dissipation for Single Operation $T_A = 25$ °C (Note 1b)	0.6	
$V_{RRM}$	Schottky Repetitive Peak Reverse Voltage	28	V
$I_O$	Schottky Average Forward Current	1	A
$T_J, T_{STG}$	Operating and Storage Junction Temperature Range	-55 to +150	°C

#### Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Single Operation)	(Note 1a)	95	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Single Operation)	(Note 1b)	210	

#### Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
3T	FDFME2P823ZT	MicroFET 1.6x1.6 <b>Thin</b>	7"	8 mm	5000 units

**Electrical Characteristics**  $T_J = 25\text{ }^\circ\text{C}$  unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
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**Off Characteristics**

$BV_{DSS}$	Drain to Source Breakdown Voltage	$I_D = -250\text{ }\mu\text{A}$ , $V_{GS} = 0\text{ V}$	-20			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = -250\text{ }\mu\text{A}$ , referenced to $25\text{ }^\circ\text{C}$		-12		mV/ $^\circ\text{C}$
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = -16\text{ V}$ , $V_{GS} = 0\text{ V}$			-1	$\mu\text{A}$
$I_{GSS}$	Gate to Source Leakage Current	$V_{GS} = \pm 8\text{ V}$ , $V_{DS} = 0\text{ V}$			$\pm 10$	$\mu\text{A}$

**On Characteristics**

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$ , $I_D = -250\text{ }\mu\text{A}$	-0.4	-0.6	-1.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = -250\text{ }\mu\text{A}$ , referenced to $25\text{ }^\circ\text{C}$		2		mV/ $^\circ\text{C}$
$r_{DS(on)}$	Drain to Source On Resistance	$V_{GS} = -4.5\text{ V}$ , $I_D = -2.3\text{ A}$		95	142	m $\Omega$
		$V_{GS} = -2.5\text{ V}$ , $I_D = -1.8\text{ A}$		120	213	
		$V_{GS} = -1.8\text{ V}$ , $I_D = -1.5\text{ A}$		150	331	
		$V_{GS} = -1.5\text{ V}$ , $I_D = -1.2\text{ A}$		190	530	
		$V_{GS} = -4.5\text{ V}$ , $I_D = -2.3\text{ A}$ , $T_J = 125\text{ }^\circ\text{C}$		128	190	
$g_{FS}$	Forward Transconductance	$V_{DS} = -4.5\text{ V}$ , $I_D = -2.3\text{ A}$		7		S

**Dynamic Characteristics**

$C_{iss}$	Input Capacitance	$V_{DS} = -10\text{ V}$ , $V_{GS} = 0\text{ V}$ , $f = 1\text{ MHz}$		305	405	pF
$C_{oss}$	Output Capacitance			55	75	pF
$C_{rss}$	Reverse Transfer Capacitance			50	75	pF

**Switching Characteristics**

$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = -10\text{ V}$ , $I_D = -1\text{ A}$ $V_{GS} = -4.5\text{ V}$ , $R_{GEN} = 6\text{ }\Omega$		4.7	10	ns
$t_r$	Rise Time			4.8	10	ns
$t_{d(off)}$	Turn-Off Delay Time			33	53	ns
$t_f$	Fall Time			16	29	ns
$Q_g$	Total Gate Charge		$V_{DD} = -10\text{ V}$ , $I_D = -2.3\text{ A}$ $V_{GS} = -4.5\text{ V}$		5.5	7.7
$Q_{gs}$	Gate to Source Gate Charge			0.6		nC
$Q_{gd}$	Gate to Drain "Miller" Charge			1.4		nC

**Drain-Source Diode Characteristics**

$V_{SD}$	Source to Drain Diode Forward Voltage	$V_{GS} = 0\text{ V}$ , $I_S = -0.9\text{ A}$ (Note 2)		-0.8	-1.2	V
$t_{rr}$	Reverse Recovery Time	$I_F = -2.3\text{ A}$ , $di/dt = 100\text{ A}/\mu\text{s}$		16	29	ns
$Q_{rr}$	Reverse Recovery Charge			4.4	10	nC

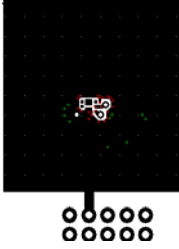
**Schottky Diode Characteristics**

$I_R$	Reverse Leakage	$V_R = 28\text{ V}$	$T_J = 25\text{ }^\circ\text{C}$		15	100	$\mu\text{A}$
			$T_J = 85\text{ }^\circ\text{C}$		0.46	4.7	mA
$V_F$	Forward Voltage	$I_F = 1\text{ A}$	$T_J = 25\text{ }^\circ\text{C}$		0.47	0.57	V
			$T_J = 85\text{ }^\circ\text{C}$		0.45		
$V_F$	Forward Voltage	$I_F = 500\text{ mA}$	$T_J = 25\text{ }^\circ\text{C}$		0.38	0.48	V
			$T_J = 85\text{ }^\circ\text{C}$		0.33		

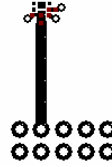
## Electrical Characteristics

### Notes:

1.  $R_{\theta JA}$  is determined with the device mounted on a 1 in<sup>2</sup> oz. copper pad on a 1.5 x 1.5 in. board of FR-4 material.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta JA}$  is determined by the user's board design.



a. 95 °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper.

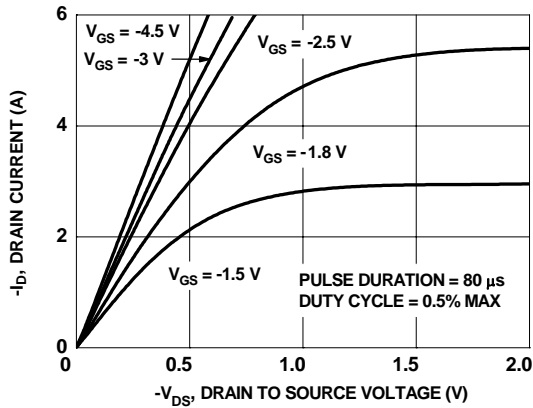


b. 210 °C/W when mounted on a minimum pad of 2 oz copper.

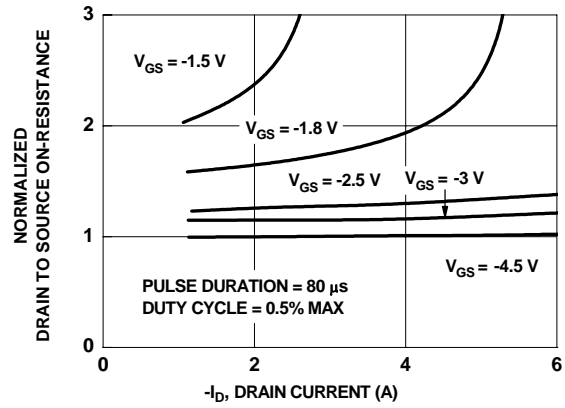
2. Pulse Test: Pulse Width < 300μs, Duty cycle < 2.0%.

3. The diode connected between the gate and source serves only as protection ESD. No gate overvoltage rating is implied.

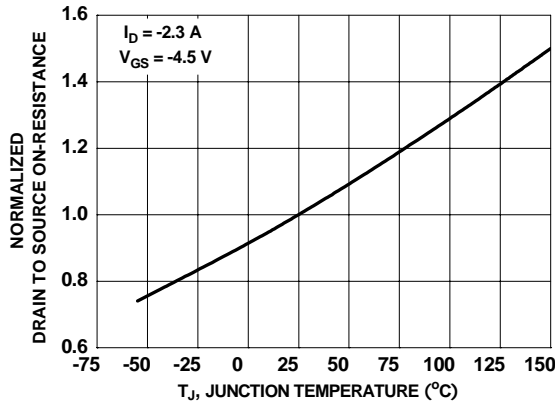
**Typical Characteristics**  $T_J = 25^\circ\text{C}$  unless otherwise noted



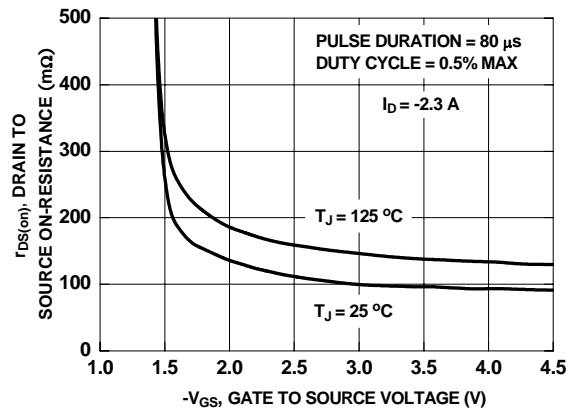
**Figure 1. On Region Characteristics**



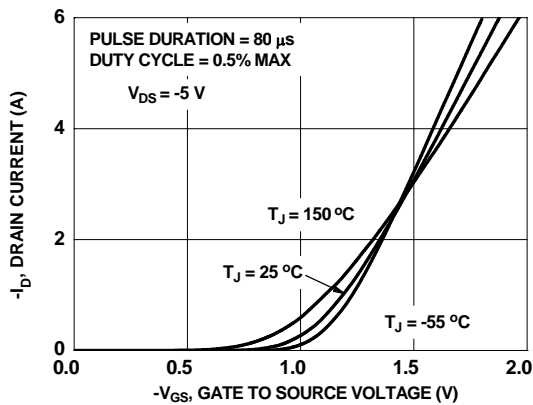
**Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage**



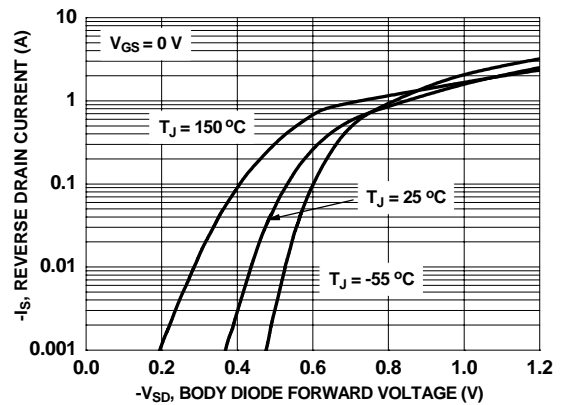
**Figure 3. Normalized On Resistance vs Junction Temperature**



**Figure 4. On-Resistance vs Gate to Source Voltage**

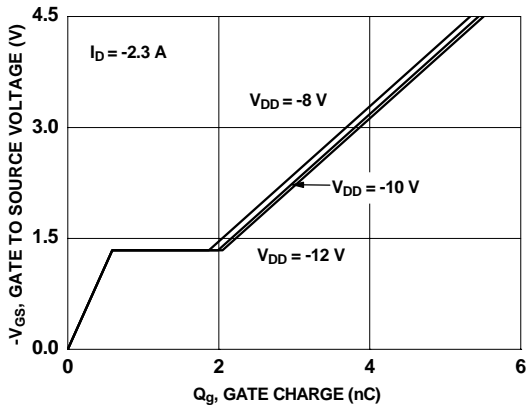


**Figure 5. Transfer Characteristics**

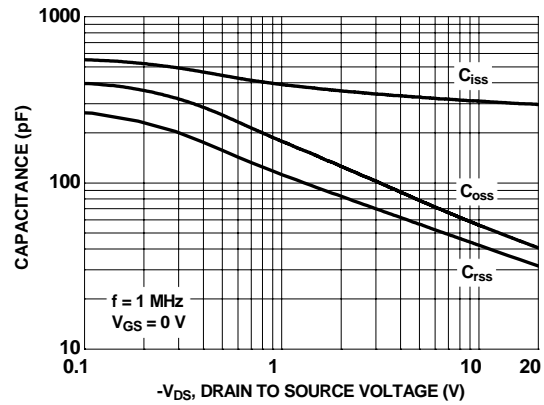


**Figure 6. Source to Drain Diode Forward Voltage vs Source Current**

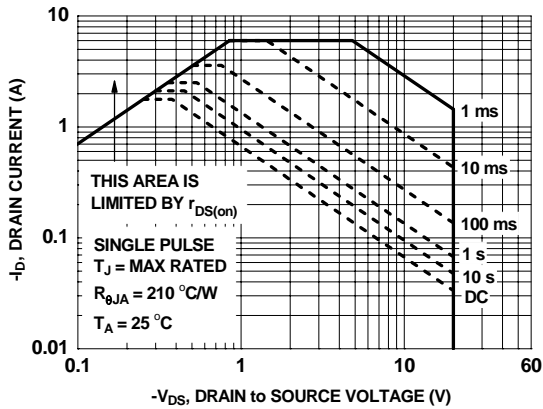
**Typical Characteristics**  $T_J = 25^\circ\text{C}$  unless otherwise noted



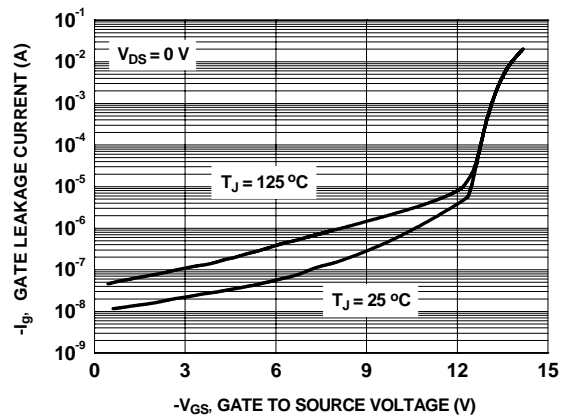
**Figure 7. Gate Charge Characteristics**



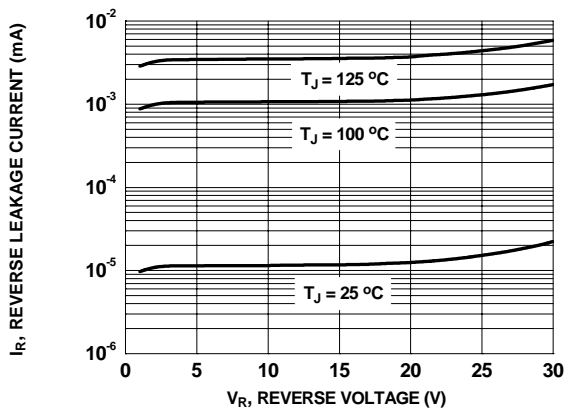
**Figure 8. Capacitance vs Drain to Source Voltage**



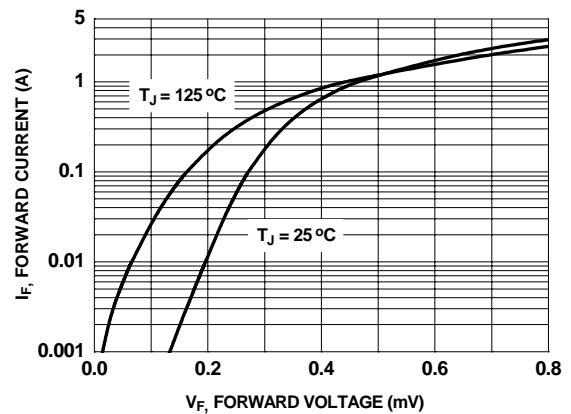
**Figure 9. Forward Bias Safe Operating Area**



**Figure 10. Gate Leakage Current vs Gate to Source Voltage**



**Figure 11. Schottky Diode Reverse Current**



**Figure 12. Schottky Diode Forward Voltage**

Typical Characteristics  $T_J = 25^\circ\text{C}$  unless otherwise noted

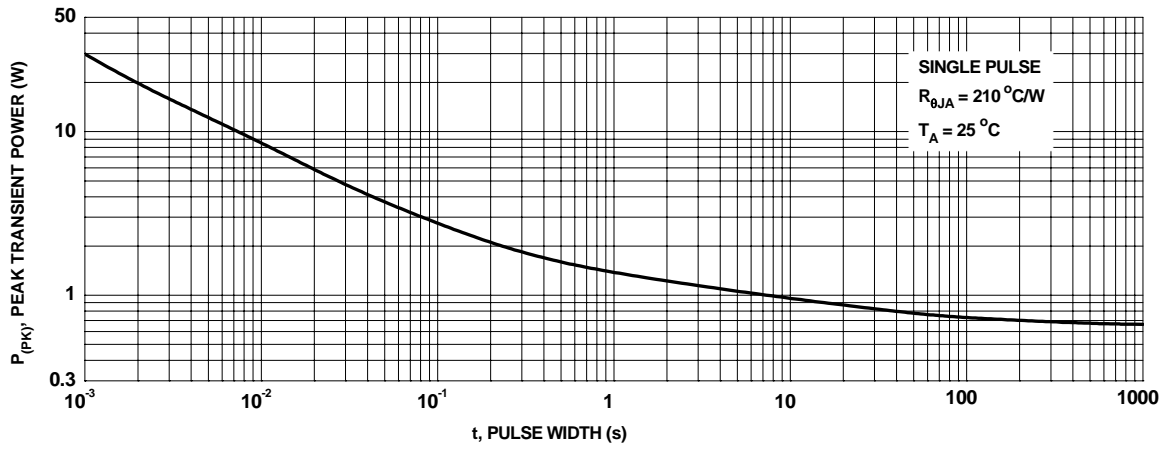


Figure 13. Single Pulse Maximum Power Dissipation

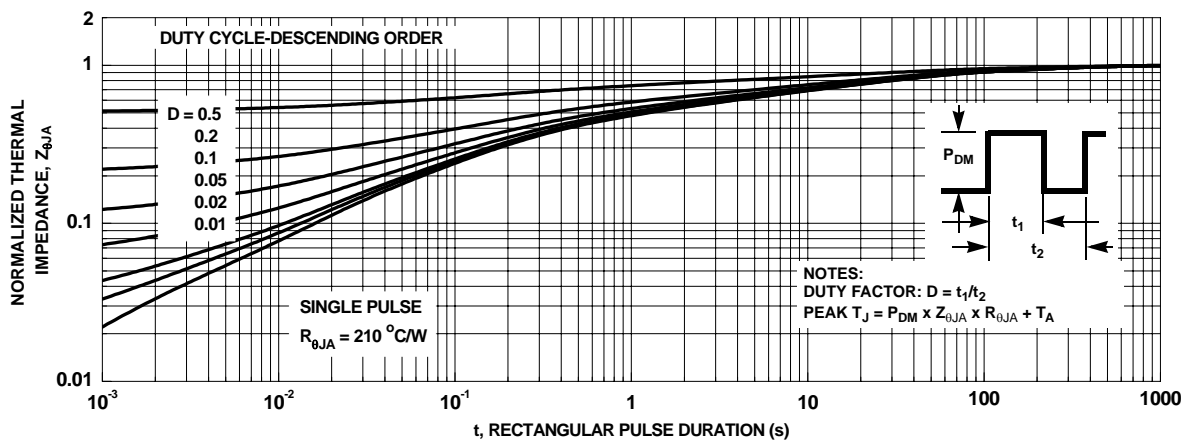
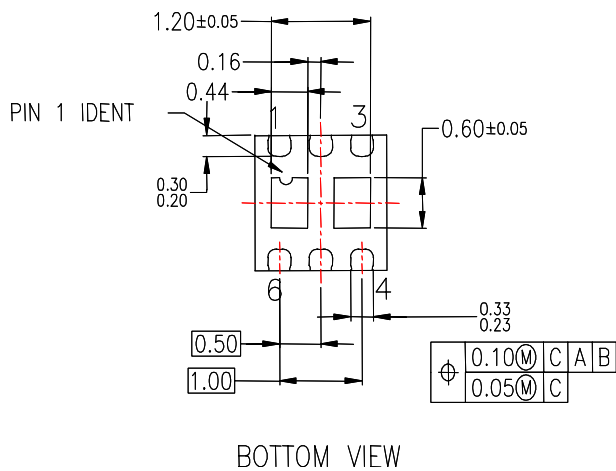
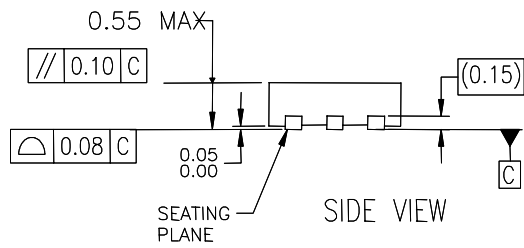
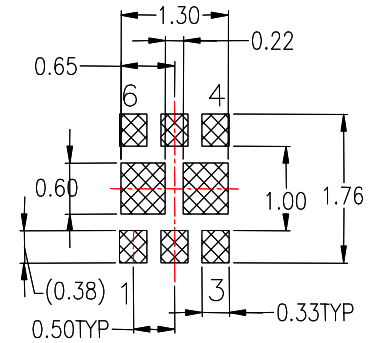
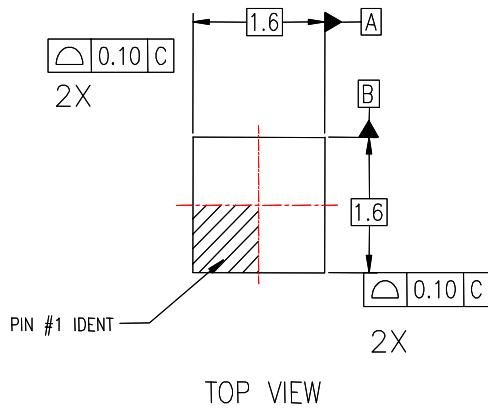


Figure 14. Junction-to-Ambient Transient Thermal Response Curve

FDFME2P823ZT Integrated P-Channel PowerTrench<sup>®</sup> MOSFET and Schottky Diode

### Dimensional Outline and Pad Layout



FDFME2P823ZT Integrated P-Channel PowerTrench<sup>®</sup> MOSFET and Schottky Diode



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